<u>TOSHIBA</u>

TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (U-MOSIII)

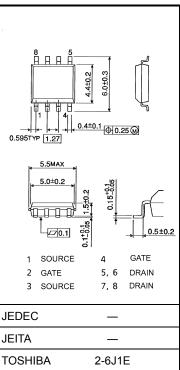
TPC8208

Lithium Ion Battery Applications Notebook PC Applications Portable Equipment Applications

- Small footprint due to small and thin package
- Low drain-source ON resistance: R_{DS} (ON) = 38 m Ω (typ.)
- High forward transfer admittance: $|Y_{fs}| = 6.3 \text{ S} (typ.)$
- Low leakage current: $I_{DSS} = 10 \ \mu A \ (max) \ (V_{DS} = 20 \ V)$
- Enhancement mode: V_{th} = 0.5 to 1.2 V (V_{DS} = 10 V, I_D = 200 μA)

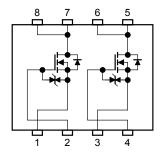
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Char	acteristics	Symbol	Rating	Unit	
Drain-source vol	tage	V _{DSS}	20	V	
Drain-gate voltag	ge (R _{GS} = 20 kΩ)	V _{DGR}	20	V	
Gate-source voltage		V _{GSS}	±12	V	
Drain current	DC (Note 1)	I _D	5	A	
Drain current	Pulse (Note 1)	I _{DP}	$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$		
Drain power dissipation (t = 10 s) (Note 2a)	Single-device operation (Note 3a)	P _{D (1)}	1.5		
	Single-device value at dual operation (Note 3b)	P _{D (2)}	1.1	W	
Drain power dissipation (t = 10 s) (Note 2b)	Single-device operation (Note 3a)	P _{D (1)}	0.75	W	
	Single-device value at dual operation (Note 3b)	P _{D (2)}	0.45		
(Note 2b) at dual operation		E _{AS}	16.3	mJ	
(Note 4) Avalanche current		I _{AR}	5	А	
Repetitive avalanche energy Single-device value at dual operation (Note 2a, 3b, 5)		E _{AR}	0.1	mJ	
Channel temperature		T _{ch}	150	°C	
Storage temperature range		T _{stg}	–55 to 150	°C	

Absolute Maximum Ratings (Ta = 25°C)



Weight: 0.080 g (typ.)

Circuit Configuration



Note: Note 1, Note 2, Note 3, Note 4 and Note 5: See the next page.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc.).

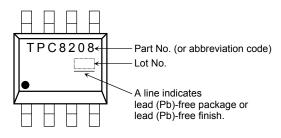
This transistor is an electrostatic-sensitive device. Please handle with caution.

Unit: mm

Thermal Characteristics

Characteristics	Symbol	Max	Unit		
Thermal resistance, channel to embiant	Single-device operation (Note 3a)	R _{th (ch-a) (1)}	83.3	°C/W	
Thermal resistance, channel to ambient (t = 10 s) (Note 2a)	Single-device value at dual operation (Note 3b)	R _{th (ch-a) (2)}	114		
Thermal resistance, channel to ambient	Single-device operation (Note 3a)	R _{th (ch-a) (1)}	167		
(t = 10 s) (Note 2b)	Single-device value at dual operation (Note 3b)	R _{th} (ch-a) (2)	278	°C/W	

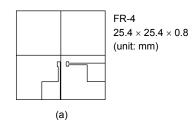
Marking (Note 6)



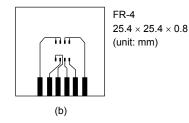
Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2:

a) Device mounted on a glass-epoxy board (a)



b) Device mounted on a glass-epoxy board (b)

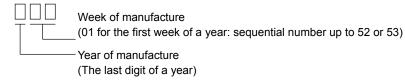


Note 3:

- a) The power dissipation and thermal resistance values are shown for a single device. (During single-device operation, power is only applied to one device.)
- b) The power dissipation and thermal resistance values are shown for a single device. (During dual operation, power is evenly applied to both devices.)

Note 4: $V_{DD} = 16 \text{ V}, \text{ T}_{ch} = 25^{\circ}\text{C}$ (initial), L = 0.5 mH, R_G = 25 Ω , I_{AR} = 5 A

- Note 5: Repetitive rating:pulse width limited by maximum channel temperature
- Note 6: on lower left of the marking indicates Pin 1.
 - Weekly code: (Three digits)



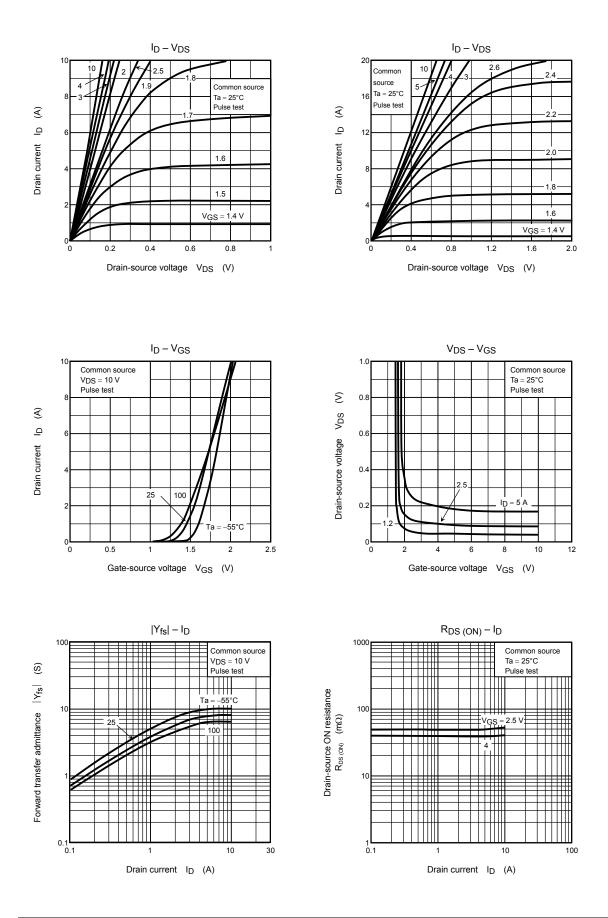
Electrical Characteristics (Ta = 25°C)

Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cur	rent	I _{GSS}	$V_{GS}=\pm 10~V,~V_{DS}=0~V$	_		±10	μA
Drain cut-OFF cu			$V_{DS}=20~V,~V_{GS}=0~V$	_		10	μA
Drain-source bre	akdown voltage	V (BR) DSS	$I_D = 10 \text{ mA}, V_{GS} = 0 \text{ V}$	20	_	—	V
	ardown voltage	V (BR) DSX	$I_D = 10 \text{ mA}, V_{GS} = -12 \text{ V}$	8		—	v
Gate threshold ve	oltage	V _{th}	$V_{DS}=10~V,~I_D=200~\mu A$	0.5	_	1.2	V
			$V_{GS} = 2.0 \text{ V}, I_D = 2.5 \text{ A}$	_	57	100	
Drain-source ON resistance		R _{DS (ON)}	$V_{GS} = 2.5 \text{ V}, \text{ I}_{D} = 2.5 \text{ A}$	_	46	70	mΩ
			$V_{GS} = 4.0 \text{ V}, I_D = 2.5 \text{ A}$	_	38	50	
Forward transfer	admittance	Y _{fs}	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 2.5 \text{ A}$	3.2	6.3	_	S
Input capacitance		C _{iss}	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz		780	_	pF
Reverse transfer capacitance		C _{rss}		_	90		
Output capacitance		C _{oss}			100	_	
	Rise time	tr			5.0	_	
Quaitataine tine e	Turn-ON time	ton	$V_{GS} \stackrel{5}{\overset{0}{}_{0}} V \prod \qquad I_{D} = 2.5 \text{ A}$	_	12	_	
Switching time	Fall time	t _f	$\begin{array}{c} & & & \\ & & & & \\ & & & \\ & & & \\ & & & \\ & & & & \\ & & & \\ & & & \\ & & & \\ & & & \\ & & & \\ & & & \\ & & & \\ & &$		2.7	_	ns
	Turn-OFF time	t _{off}			21	_	
Total gate charge (gate-source plus gate-drain)		Qg	$V_{DD} \simeq 16 \text{ V}, \text{ V}_{GS} = 5 \text{ V}, \text{ I}_{D} = 5 \text{ A}$		9.5	_	
Gate-source charge 1		Q _{gs1}			2.0	—	nC
Gate-drain ("miller") charge		Q _{gd}			2.2		

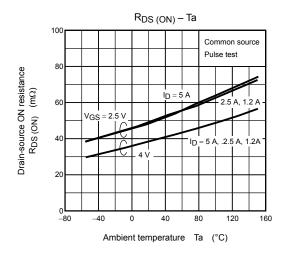
Source-Drain Ratings and Characteristics (Ta = 25°C)

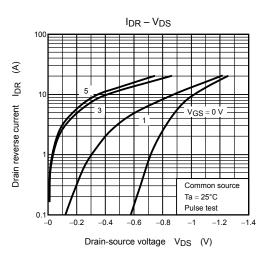
Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit
Drain reverse current	Pulse (Note 1)	I _{DRP}	—	_	_	20	А
Forward voltage (diode)		V _{DSF}	$I_{DR} = 5 \text{ A}, \text{ V}_{GS} = 0 \text{ V}$			-1.2	V

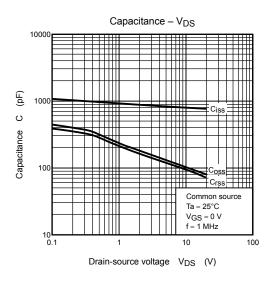
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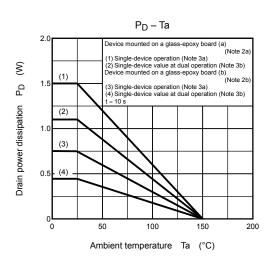


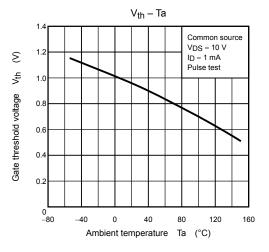
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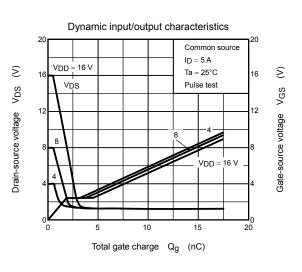


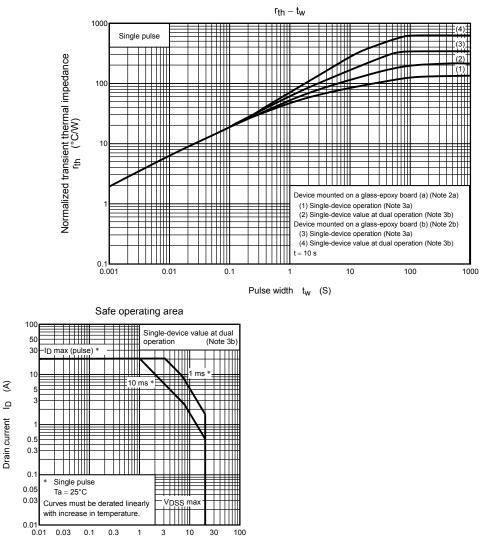












Drain-source voltage VDS (V)

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